

Search Notes

Application/Control No.

10/748,168

Examiner

Yuwen Pan

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

2682

SEARCHED

Class	Subclass	Date	Examiner
455	436,437,4 44,41.2	1/3/2005	YP
370	331		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPG-PUB,USPAT)	1/3/2005	YP